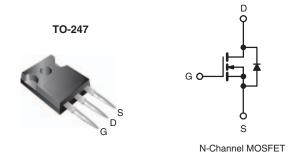


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	250			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.14		
Q <sub>g</sub> (Max.) (nC)	140			
Q <sub>gs</sub> (nC)	24			
Q <sub>gd</sub> (nC)	71			
Configuration	Single			



#### **FEATURES**

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mouting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION		
Package	TO-247	
Lond (Dh.) from	IRFP254PbF	
Lead (Pb)-free	SiHFP254-E3	
SnPb	IRFP254	
	SiHFP254	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	250	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20			
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 ^{\circ}C$	I <sub>D</sub>	23	А	
	T <sub>C</sub> = 100 °C		15		
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	92	1		
Linear Derating Factor			1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	410	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	23	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	19	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	190	W	
Peak Diode Recovery dV/dtc		dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	6-32 OF IVIS SCIEW		1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 1.2 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 23 A (see fig. 12).
- c.  $I_{SD} \le 23$  A,  $dI/dt \le 180$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP254, SiHFP254

# Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						<u>'</u>	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.39	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zana Oata Walkana D. i. C.	I <sub>DSS</sub>	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V		-	-	25	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 200 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 14 A <sup>b</sup>	-	-	0.14	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 14 A <sup>b</sup>		11	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0  MHz,  see fig. 5		-	2700	-	
Output Capacitance	C <sub>oss</sub>			-	620	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	180	-	1
Total Gate Charge	Qg		I <sub>D</sub> = 23 A, V <sub>DS</sub> = 200 V, see fig. 6 and 13 <sup>b</sup>	-	-	140	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	24	
Gate-Drain Charge	Q <sub>gd</sub>	See lig. 0 and 10	-	-	71	1	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 125 V, $I_{D}$ = 23 A, $R_{G}$ = 6.2 $\Omega$ , $R_{D}$ = 5.4 $\Omega$ , see fig. 10 <sup>b</sup>		-	15	-	ns
Rise Time	t <sub>r</sub>			-	63	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	74	-	
Fall Time	t <sub>f</sub>			-	50	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH
Internal Source Inductance	L <sub>S</sub>			-	13	-	1111
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	23	- A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	92	
Body Diode Voltage	$V_{SD}$	$T_J = 25 ^{\circ}\text{C},  I_S = 23  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 23 A, dl/dt = 100 A/μs <sup>b</sup>		-	370	560	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	4.6	6.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn	-on is dor	lominated by L <sub>S</sub> and L <sub>D</sub> )			

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

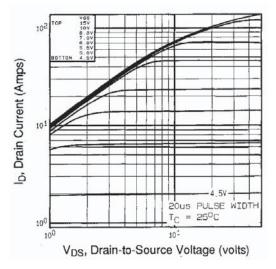


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

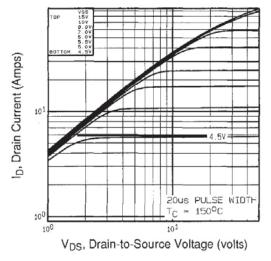


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

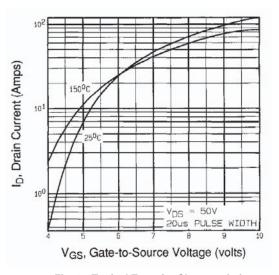


Fig. 3 - Typical Transfer Characteristics

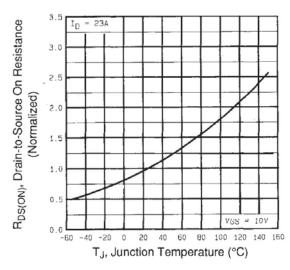


Fig. 4 - Normalized On-Resistance vs. Temperature

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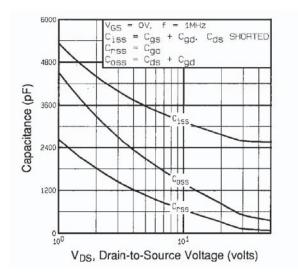


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

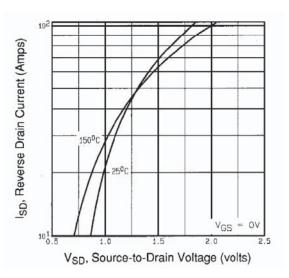


Fig. 7 - Typical Source-Drain Diode Forward Voltage

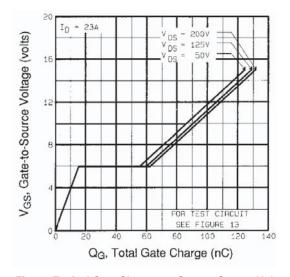


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

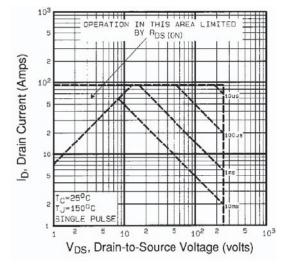


Fig. 8 - Maximum Safe Operating Area



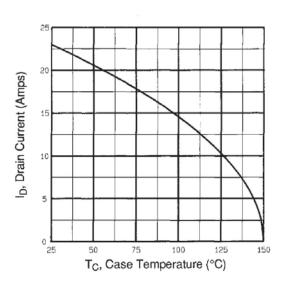


Fig. 9 - Maximum Drain Current vs. Case Temperature

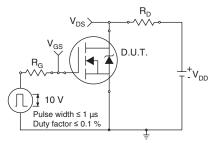


Fig. 10a - Switching Time Test Circuit

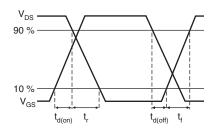


Fig. 10b - Switching Time Waveforms

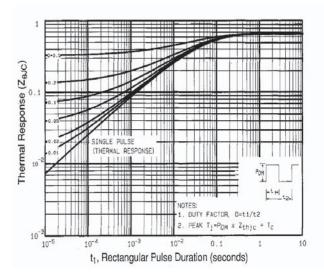


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

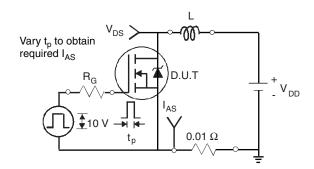


Fig. 12a - Unclamped Inductive Test Circuit

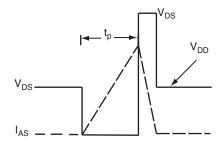


Fig. 12b - Unclamped Inductive Waveforms

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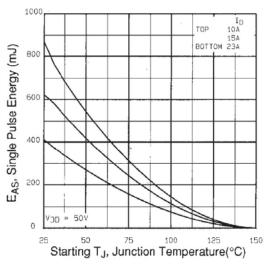


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

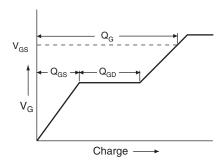


Fig. 13a - Basic Gate Charge Waveform

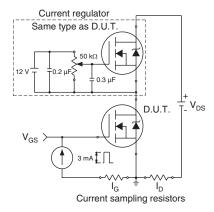
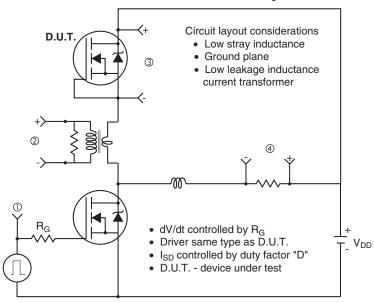
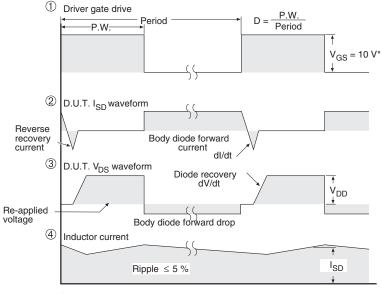


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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